

Silicon Diffused Power Transistor

BU2708AF

GENERAL DESCRIPTION

High voltage, high speed switching npn transistor in a plastic full-pack envelope. Intended for use in horizontal deflection circuits of colour television receivers. Features exceptional tolerance to base drive and collector current load variations, resulting in a low worst-case dissipation. Designed to withstand V_{CES} pulses up to 1700 V.

QUICK REFERENCE DATA

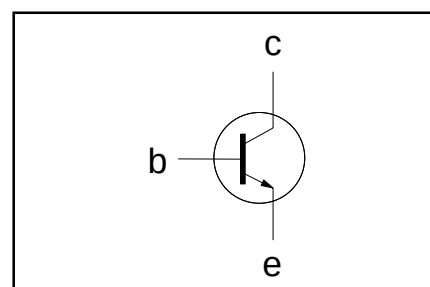
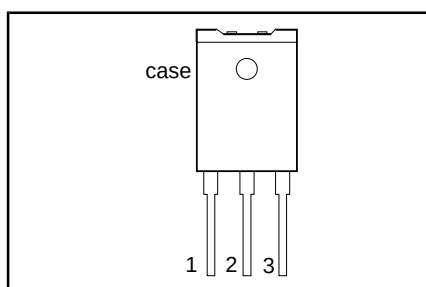
SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
V_{CESM}	Collector-emitter voltage peak value	$V_{BE} = 0 \text{ V}$	-	1700	V
V_{CEO}	Collector-emitter voltage (open base)		-	825	V
I_C	Collector current (DC)		-	8	A
I_{CM}	Collector current peak value		-	15	A
P_{tot}	Total power dissipation	$T_{hs} \leq 25^\circ\text{C}$	-	45	W
V_{CESat}	Collector-emitter saturation voltage	$I_C = 4 \text{ A}; I_B = 1.33 \text{ A}$	-	1.0	V
I_{Csat}	Collector saturation current	$f = 16 \text{ kHz}$	4	-	A
t_s	Storage time	$I_{Csat} = 4 \text{ A}; f = 16 \text{ kHz}$	4.8	5.5	μs

PINNING - SOT199

PIN CONFIGURATION

SYMBOL

PIN	DESCRIPTION
1	base
2	collector
3	emitter
case	isolated



LIMITING VALUES

Limiting values in accordance with the Absolute Maximum Rating System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{CESM}	Collector-emitter voltage peak value	$V_{BE} = 0 \text{ V}$	-	1700	V
V_{CEO}	Collector-emitter voltage (open base)		-	825	V
I_C	Collector current (DC)		-	8	A
I_{CM}	Collector current peak value		-	15	A
I_B	Base current (DC)		-	4	A
I_{BM}	Base current peak value		-	6	A
$-I_{BM}$	Reverse base current peak value ¹		-	5	A
P_{tot}	Total power dissipation	$T_{hs} \leq 25^\circ\text{C}$	-	45	W
T_{stg}	Storage temperature		-65	150	$^\circ\text{C}$
T_j	Junction temperature		-	150	$^\circ\text{C}$

ESD LIMITING VALUES

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_C	Electrostatic discharge capacitor voltage	Human body model (250 pF, 1.5 k Ω)	-	10	kV

¹ Turn-off current.

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THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
$R_{th\ j-hs}$	Junction to heatsink	without heatsink compound	-	3.7	K/W
$R_{th\ j-hs}$	Junction to heatsink	with heatsink compound	-	2.8	K/W
$R_{th\ j-a}$	Junction to ambient	in free air	35	-	K/W

ISOLATION LIMITING VALUE & CHARACTERISTIC

 $T_{hs} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V_{isol}	Repetitive peak voltage from all three terminals to external heatsink	R.H. $\leq 65\%$; clean and dustfree	-		2500	V
C_{isol}	Capacitance from T2 to external heatsink	$f = 1\text{ MHz}$	-	22	-	pF

STATIC CHARACTERISTICS

 $T_{hs} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I_{CES}	Collector cut-off current ²	$V_{BE} = 0\text{ V}; V_{CE} = V_{CESMmax}$	-	-	1.0	mA
I_{CES}		$V_{BE} = 0\text{ V}; V_{CE} = V_{CESMmax}$	-	-	2.0	mA
I_{EBO}	Emitter cut-off current	$T_j = 125\text{ }^{\circ}\text{C}$ $V_{EB} = 6\text{ V}; I_C = 0\text{ A}$	-	-	70	μA
BV_{EBO}	Emitter-base breakdown voltage	$I_B = 1\text{ mA}$	7.5	13.5	-	V
$V_{CEOsust}$	Collector-emitter sustaining voltage	$I_B = 0\text{ A}; I_C = 100\text{ mA};$ $L = 25\text{ mH}$	825	900	-	V
V_{CESat}	Collector-emitter saturation voltage	$I_C = 4\text{ A}; I_B = 1.33\text{ A}$	-	-	1.0	V
V_{BEsat}	Base-emitter saturation voltage	$I_C = 4\text{ A}; I_B = 1.33\text{ A}$	0.83	0.91	1.00	V
h_{FE}	DC current gain	$I_C = 100\text{ mA}; V_{CE} = 5\text{ V}$	-	21	-	
h_{FE}		$I_C = 4\text{ A}; V_{CE} = 1\text{ V}$	3	6	7.3	

DYNAMIC CHARACTERISTICS

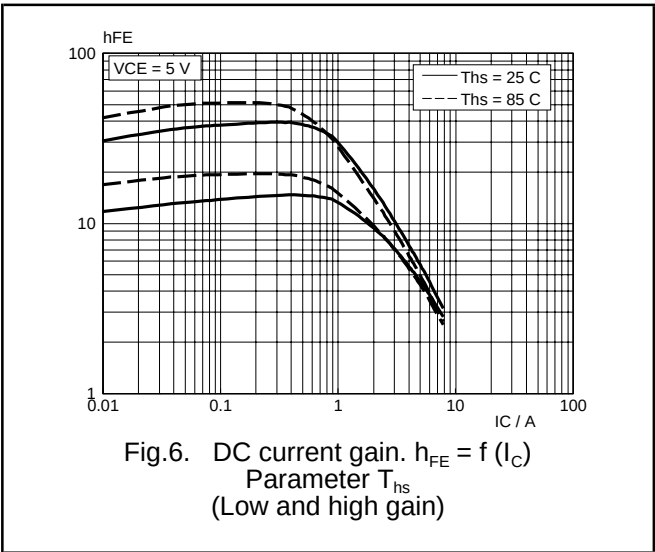
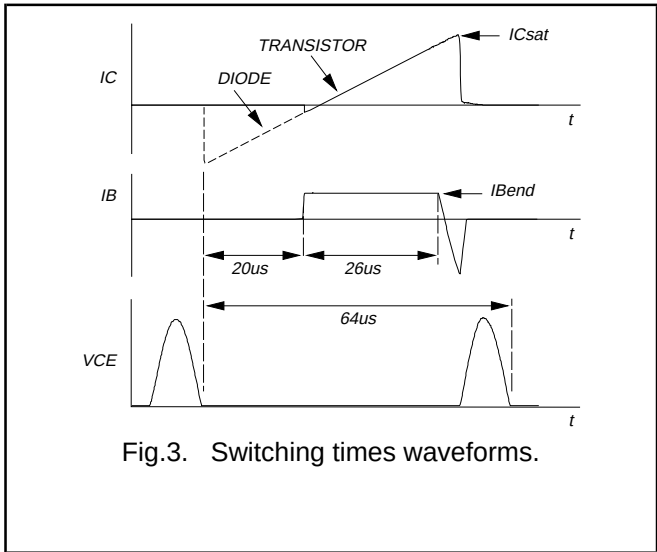
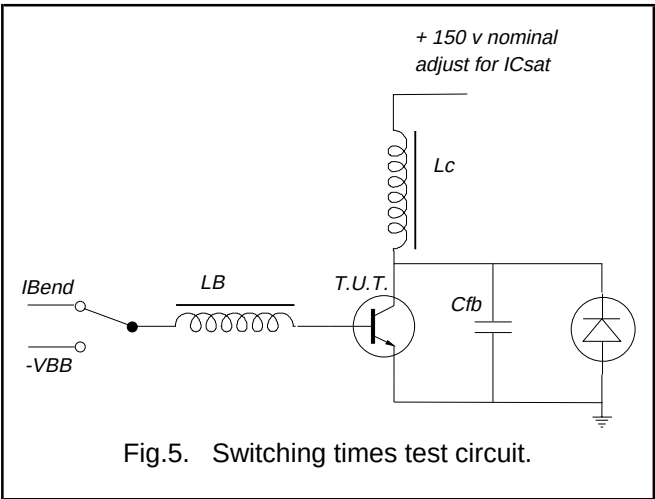
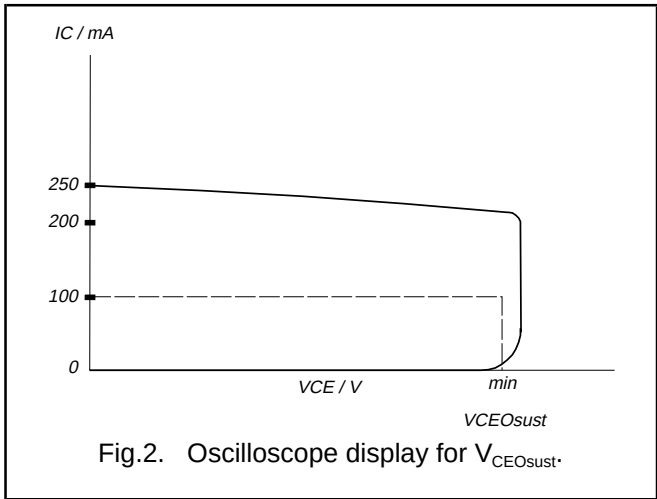
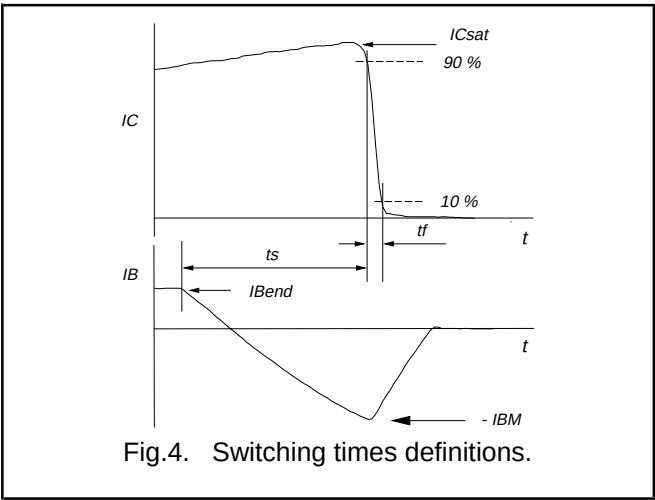
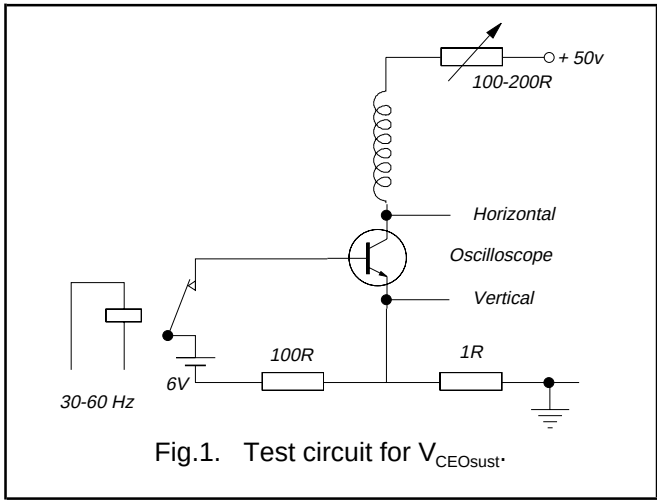
 $T_{hs} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
	Switching times (line deflection circuit 16 kHz)	$I_{Csat} = 4\text{ A}; I_{B(end)} = 0.8\text{ A}; -I_{BM} = I_{CM}/2;$ $L_B = 6\text{ }\mu\text{H}; -V_{BB} = 4\text{ V}; L_C = 1\text{ mH};$ $C_{FB} = 12.2\text{ nF}$			
t_s	Turn-off storage time		4.8	5.5	μs
t_f	Turn-off fall time		0.4	0.52	μs

² Measured with half sine-wave voltage (curve tracer).

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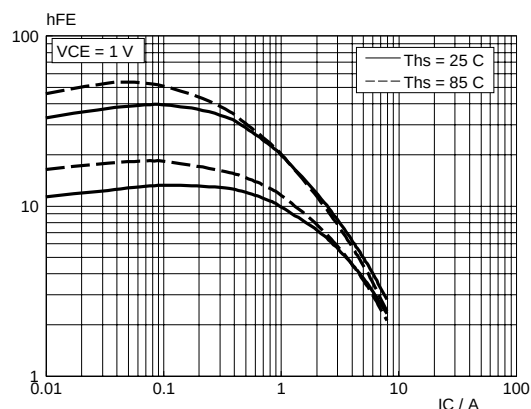


Fig.7. DC current gain. $h_{FE} = f(I_C)$
Parameter T_{HS}
(Low and high gain)

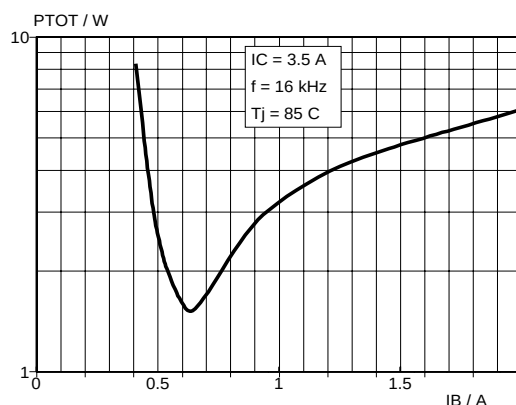


Fig.10. Limit P_{tot} ; $T_J = 85$ °C
 $P_{tot} = f(I_{B(end)})$; $I_C = 3.5$ A; $f = 16$ kHz

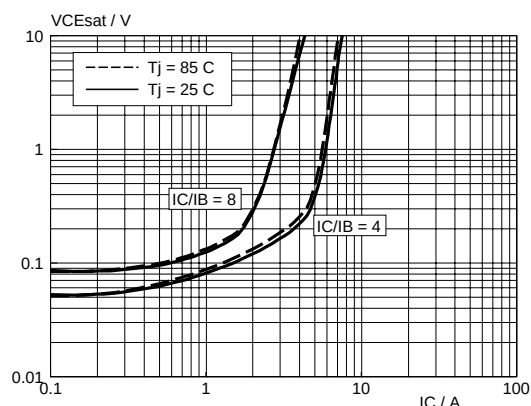


Fig.8. Typical collector-emitter saturation voltage.
 $V_{CESat} = f(I_C)$; parameter I_C/I_B

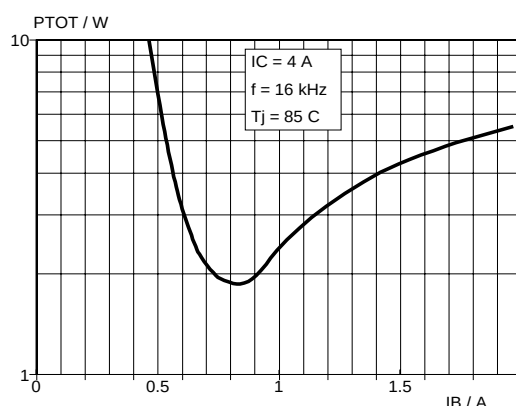


Fig.11. Limit P_{tot} ; $T_J = 85$ °C
 $P_{tot} = f(I_{B(end)})$; $I_C = 4.0$ A; $f = 16$ kHz

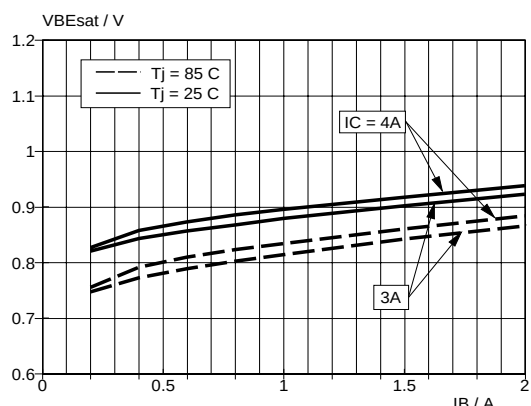


Fig.9. Typical base-emitter saturation voltage.
 $V_{BEsat} = f(I_B)$; parameter I_C

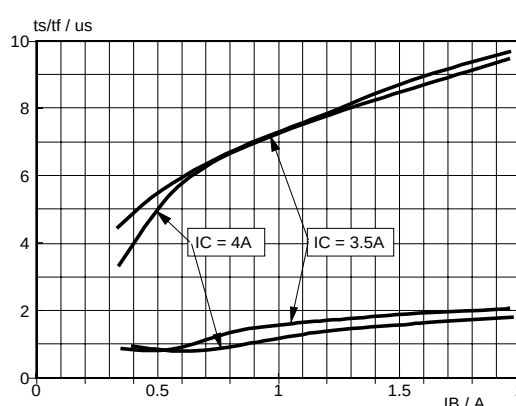


Fig.12. Limit storage and fall time.
 $t_s = f(I_B)$; $t_f = f(I_B)$; parameter I_C ; $T_J = 85$ °C; $f = 16$ kHz

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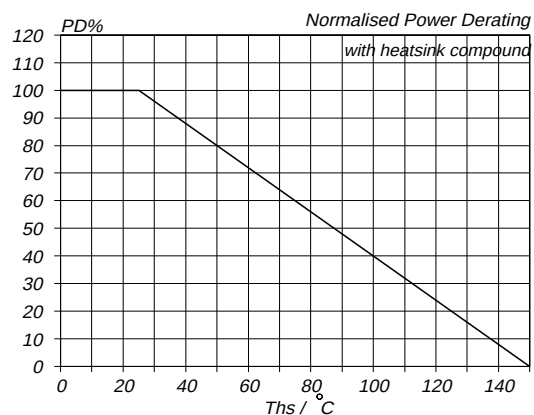


Fig.13. Normalised power dissipation.
 $PD\% = 100 \cdot PD / PD_{25^\circ C} = f(T_{jhs})$

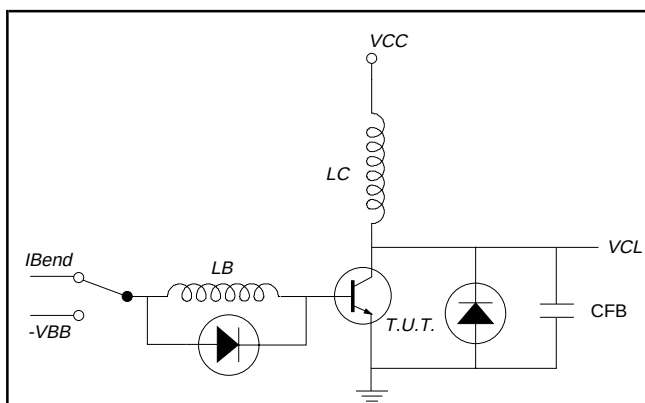


Fig.15. Test Circuit RBSOA. $V_{CC} = 150 \text{ V}$;
 $-V_{BB} = 1 - 4 \text{ V}$;
 $L_C = 1 \text{ mH}$; $V_{CL} = 1500 \text{ V}$; $L_B = 1 - 3 \mu\text{H}$;
 $C_{FB} = 1 - 4 \text{ nF}$; $I_{B(end)} = 0.8 - 4 \text{ A}$

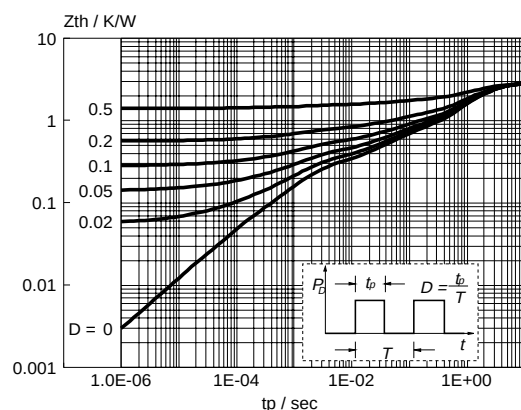


Fig.14. Transient thermal impedance.
 $Z_{th-jhs} = f(t)$; parameter $D = t_p / T$

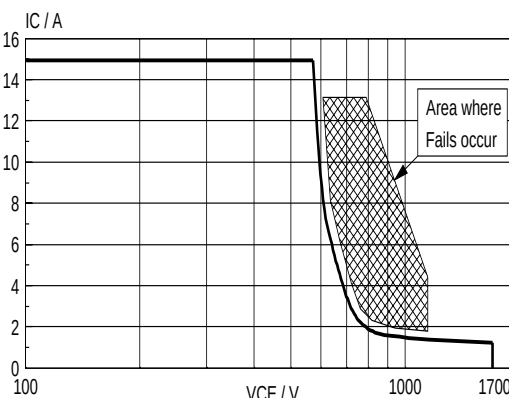
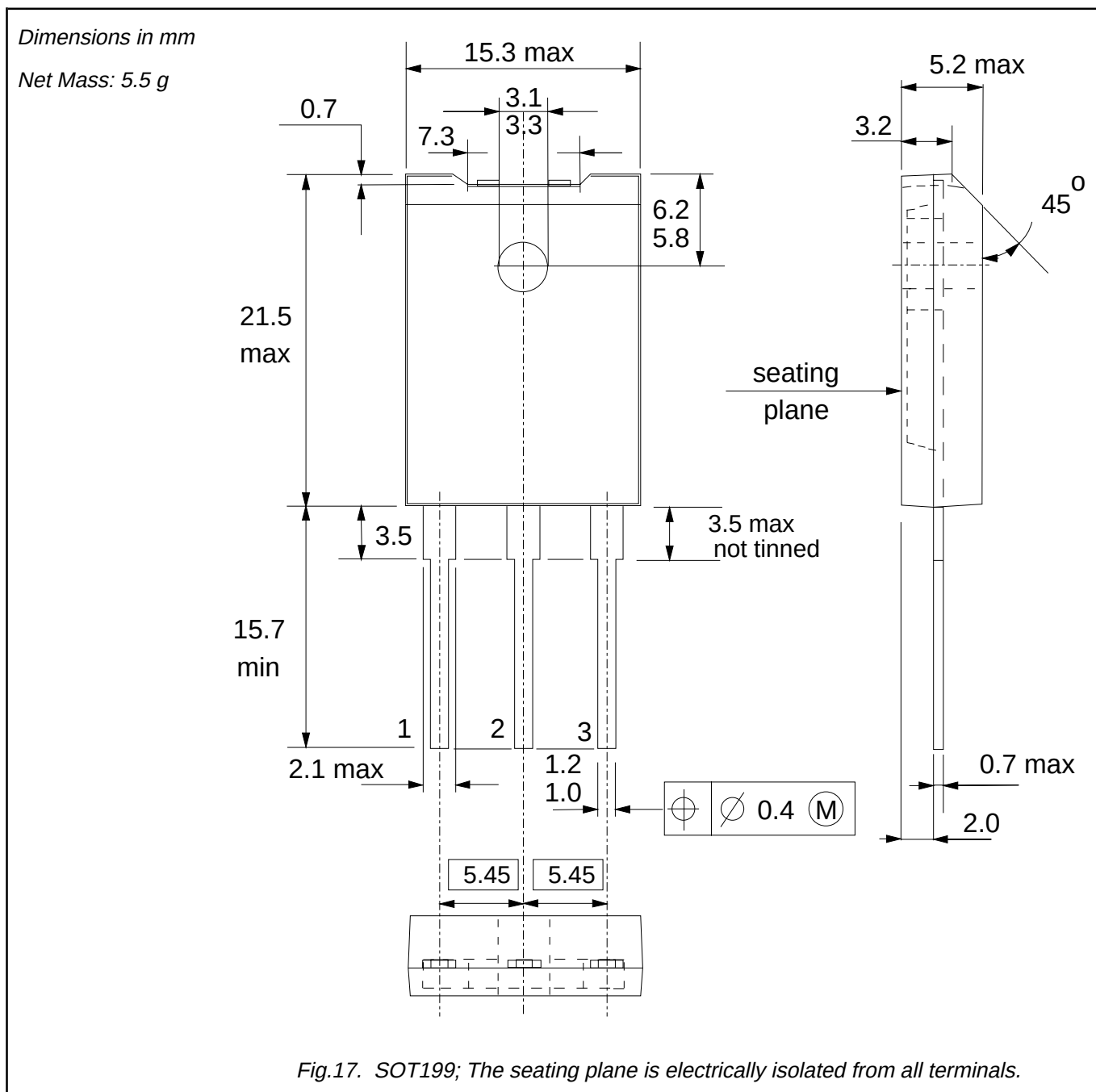


Fig.16. Reverse bias safe operating area. $T_j \leq T_{jmax}$

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MECHANICAL DATA



Notes

1. Refer to mounting instructions for F-pack envelopes.
2. Epoxy meets UL94 V0 at 1/8".

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DEFINITIONS

Data sheet status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
Application information	
Where application information is given, it is advisory and does not form part of the specification.	
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